NST489AMT1, NSVT489AMT1G

High Current Surface Mount NPN Silicon Low V_{CE(sat)} Switching Transistor for Load Management in **Portable Applications**

Features

- AEC-Q101 Qualified and PPAP Capable
- NSV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements
- Pb–Free Packages are Available*

MAXIMUM RATINGS (T_A = 25°C)

Rating	Symbol	Max	Unit	
Collector-Emitter Voltage	V _{CEO}	30	V	
Collector-Base Voltage	V _{CBO}	50	V	
Emitter-Base Voltage	V _{EBO}	5.0	V	
Collector Current – Continuous	Ι _C	2.0	А	
Collector Current – Peak	I _{CM}	3.0	А	

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Total Device Dissipation T _A = 25°C Derate above 25°C	P _D (Note 1)	535 4.3	mW mW/°C
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$ (Note 1)	234	°C/W
Total Device Dissipation T _A = 25°C Derate above 25°C	P _D (Note 2)	1.180 9.4	W mW/°C
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$ (Note 2)	106	°C/W
Thermal Resistance, Junction-to-Lead #1	R _{θJL} (Note 1) R _{θJL} (Note 2)	110 50	°C/W °C/W
Total Device Dissipation (Single Pulse < 10 s)	P _{Dsingle} (Notes 2 and 3)	1.75	W
Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. FR-4 with 1 oz and 3.9 mm² of copper area. 2. FR-4 with 1 oz and 645 mm² of copper area.

3. Refer to Figure 8.

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



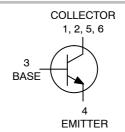
ON Semiconductor®

http://onsemi.com

30 VOLTS, 3.0 AMPS NPN TRANSISTOR



CASE 318G STYLE 6



DEVICE MARKING



N2 = Specific Device Code

= Date Code* М

= Pb-Free Package

(Note: Microdot may be in either location)

*Date Code orientation may vary depending upon manufacturing location.

ORDERING INFORMATION

Device	Package	Shipping [†]
NST489AMT1	TSSOP-6	3,000 / Tape & Reel
NST489AMT1G	TSSOP-6 (Pb-Free)	3,000 / Tape & Reel
NSVT489AMT1G	TSSOP-6 (Pb-Free)	3,000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

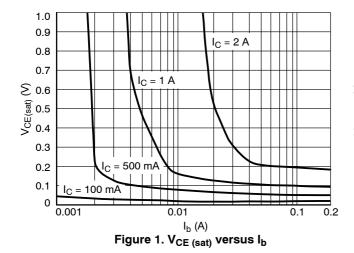
NST489AMT1, NSVT489AMT1G

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

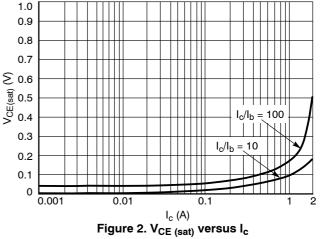
Characteristic		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Collector – Emitter Breakdown Voltage (I _C = 10 mA, I _B = 0)		V _{(BR)CEO}	30	-	-	V
Collector-Base Breakdown Voltage ($I_C = 0.1 \text{ mA}, I_E = 0$)		V _{(BR)CBO}	50	-	-	V
Emitter – Base Breakdown Voltage ($I_E = 0.1 \text{ mA}, I_C = 0$)		V _{(BR)EBO}	5.0	-	-	V
Collector Cutoff Current (V _{CB} = 30 V, $I_E = 0$)		I _{CBO}	-	-	0.1	μA
Collector-Emitter Cutoff Current (V _{CES} = 30 V)		I _{CES}	-	-	0.1	μA
Emitter Cutoff Current (V _{EB} = 4.0 V)		I _{EBO}	-	-	0.1	μA
ON CHARACTERISTICS						
	$0 \text{ mA}, V_{CE} = 5.0 \text{ V}$	h _{FE}	300 300	- 500	- 900	

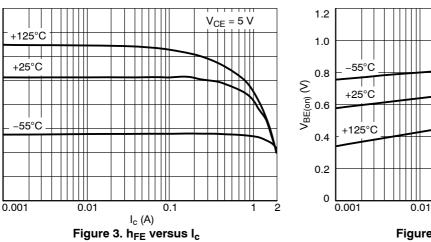
	$(I_{C} = 1.0 \text{ Hz}, V_{CE} = 5.0 \text{ V})$ $(I_{C} = 0.5 \text{ A}, V_{CE} = 5.0 \text{ V})$ $(I_{C} = 1.0 \text{ A}, V_{CE} = 5.0 \text{ V})$	νε	300 200	- 500 -	900 _	
Collector - Emitter Saturation Voltage (Note 4)		V _{CE(sat)}		0.10 0.06 0.05	0.200 0.125 0.075	V
Base – Emitter Saturation Voltage (Note 4) (I_C = 1.0 A, I_B = 0.1 A)		V _{BE(sat)}	-	-	1.1	V
Base – Emitter Turn–on Voltage (Note 4) (I_C = 1.0 A, V_{CE} = 2.0 V)		V _{BE(on)}	-	-	1.1	V
Cutoff Frequency (I _C = 100 mA, V _{CE} = 5.0 V, f = 100 MHz		f _T	200	300	-	MHz
Output Capacitance (f = 1.0 MHz)		C _{obo}	-	-	15	pF

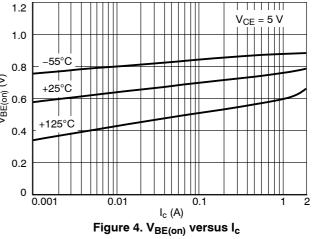
4. Pulsed Condition: Pulse Width \leq 300 µsec, Duty Cycle \leq 2%.



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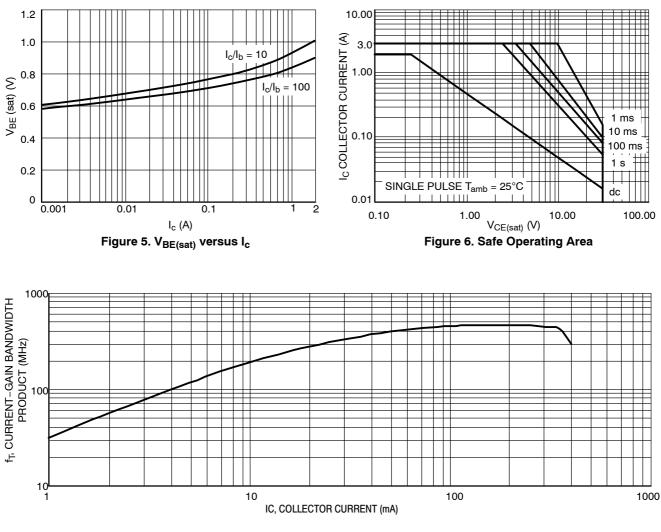


Figure 7. f_T (MHZ) versus I_C (mA) V_{CE} = 5.0 V

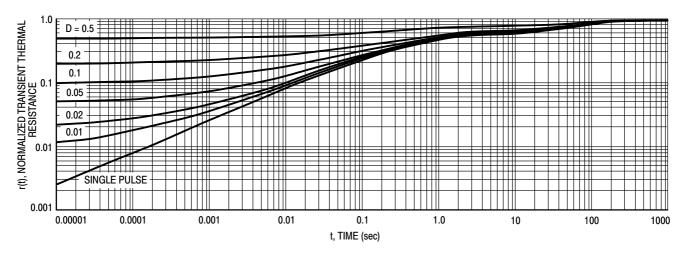
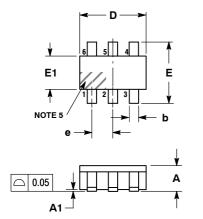
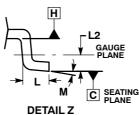


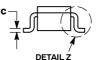
Figure 8. Normalized Thermal Response

PACKAGE DIMENSIONS









NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. 2

- CONTROLLING DIMENSION: MILLIMETERS. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM
- З. LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL. DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR 4
- GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE. DIMENSIONS D AND E1 ARE DETERMINED AT DATUM H. 5. PIN ONE INDICATOR MUST BE LOCATED IN THE INDICATED ZONE.

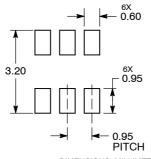
	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.01	0.06	0.10	
b	0.25	0.38	0.50	
c	0.10	0.18	0.26	
D	2.90	3.00	3.10	
E	2.50	2.75	3.00	
E1	1.30	1.50	1.70	
е	0.85	0.95	1.05	
L	0.20	0.40	0.60	
L2	0.25 BSC			
M	0°	-	10°	

STYLE 6:

PIN 1. COLLECTOR 2. COLLECTOR 3. BASE

4. EMITTER COLLECTOR 5. 6.

RECOMMENDED SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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